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U.S. Department of Commerce, Patent and Trademark Office			<u></u>		Attorney Docket No.:	026-0041		
					sypplication No.:	10/814,816		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Applicant(s):	Ligang Zhang et al.				
(Use several sheets if necessary)				Filing Date:	March 31, 200	14		
			Group Art Unit:	Not yet assigned				
			Date Submitted:	April 30, 2004				
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.					ot in			

PTO/SB/08A (Substitute for form 1449/PTO)	Attorney Docket No.: 026-0041
	Application No.: 10/814,816
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	First Named Inventor: Ligang Zhang
OIPE	Filing Date: March 31, 2004
SEP 2 2 5	Group Art Unit: 28/1
27 2005 8	Examiner Name: Jennifer E. Matisiak
Sheet I of I	Date Submitted: September 23, 2005

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Examiner Sig	nature	Junto E Met	tical	Date Considered	3-17-06	

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²See Kinds Codes of USPTO Patent Documents at <u>www.uspto.gov</u> or MPEP 901.04.

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⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible.

⁶Applicant is to place a check mark here if English language Translation is attached.

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				pplication No.:	10/814,816		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				First Named Inventor: Ligang Zhang			
OIPE			iling Date:	March 31, 2004			
70			Group Art Unit:	2811			
SEP 2 7 2005 ®			Examiner Name:	Jennifer E. Matisiak			
Show Lot 1				Pate Submitted:	September 23, 2005		
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